

SSC8LA6GT8

N-Channel Enhancement Mode MOSFET

> Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	ID
100V	±20V	15mΩ@10V	45A
	<u> - 20 v</u>	18mΩ@4V5	75/4

Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

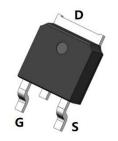
Applications

- Motor Drive Control
- Portable Devices
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

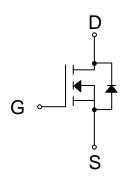
Ordering Information

Device	Package	Shipping
SSC8LA6GT8	TO-252-2L	2500/Reel

Pin Configuration



TO-252-2L (Top View)



Pin Configuration



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit		
V _{DSS}	Drain-to-Source Voltage		100	V	
V _{GSS}	Gate-to-Source Volta	ge	±20	V	
	Caratina and Danier Commented	T _C =25℃	45	^	
l _D	Continuous Drain Current	tage $T_{C}=25^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ ent b $T_{C}=100^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ H Single Pulse H Single Pulse perature	26	A	
	Outine Duis Outst	inuous Drain Current d $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ Pulsed Drain Current b $T_{C}=25^{\circ}C$ $T_{C}=100^{\circ}C$	13		
IDSM	Continuous Drain Current	T _A =70°C	10	A	
I _{DM}	Pulsed Drain Curren	Pulsed Drain Current b		Α	
Б		Tc=25℃	62.5	34/	
P _D		25	W		
Г.	Daniel Biolinetics 6	T _A =25℃	4.2	34/	
P _{DSM}	Power Dissipation ^a	T _A =70°C	2.7	W	
las	Avalanche Energy ^b L=0.5mH Single Pulse		12	Α	
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		36	mJ	
TJ	Operation junction temperature		-55~150	%	
T _{STG}	Storage temperature ra	ange	-55~150	$^{\circ}$	

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
ReJA	Junction-to-Ambient Thermal Resistance a	30	°C/W
R _{θJC}	Junction-to-Case Thermal Resistance	2	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25 °C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.0 www.sscsemi.com Analog Future



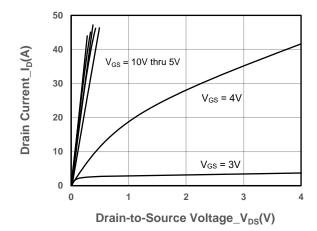


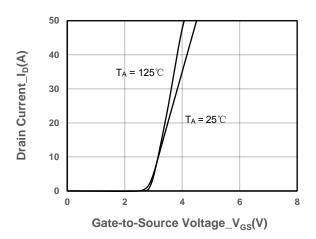
\succ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250µA	100			V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250uA$	1	1.7	2.5	V
Drain-Source On-Resistance	D	$V_{GS} = 10V, I_D = 20A$ $V_{GS} = 4.5V, I_D = 10A$		15	19	mΩ
Dialii-Source Oil-Resistance	KDS(on)			18	23	
Zero Gate Voltage Drain Current	loss	V _{DS} = 100V, V _{GS} = 0V			1	μA
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 10A			1.4	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		1		Ω
Input Capacitance	C _{ISS}	\(- 50\(\) - 0\(\)		1080		
Output Capacitance	Coss	$V_{DS} = 50V$, $V_{GS} = 0V$, $f = 1MHz$		300		pF
Reverse Transfer Capacitance	C _{RSS}	I – IIVIDZ		20		
Total Gate Charge	Q _G	V - 40V V - 50V		18		
Gate to Source Charge	Q _{GS}	$V_{GS} = 10V, V_{DS} = 50V,$ $I_{D} = 20A$		4.6		nC
Gate to Drain Charge	Q _{GD}	1D – 20A		4.3		
Turn-on Delay Time	T _{D(ON)}			4.8		
Rise Time	Tr	V _{GS} = 10V, V _{DS} = 50V,		24]
Turn-off Delay Time	T _{D(OFF)}	$R_L = 2.5\Omega, R_G = 1.6\Omega$		17		ns
Fall Time	T _f			8.6		
Diode Recovery Time	Trr	I⊧=20A, di/dt=100A/us		45		ns
Diode Recovery Charge	Qrr	I _F =20A, di/dt=100A/us		50		nC



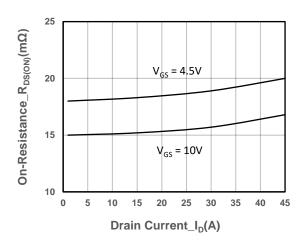
➤ Typical Performance Characteristics (T_A=25°C unless otherwise noted)

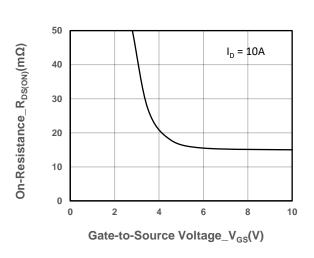




Output Characteristics

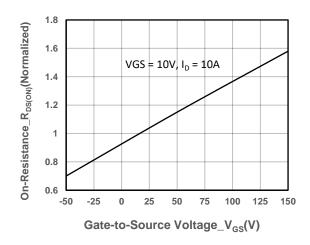
Transfer Characteristics

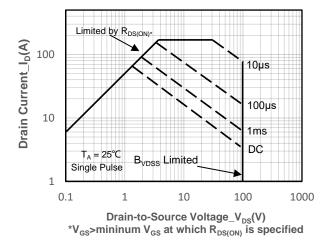




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



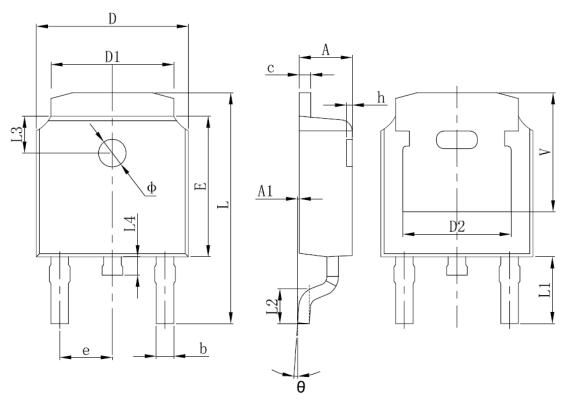


On-Resistance vs. Junction Temperature

Safe Operating Area vs. Junction-to-Ambient



Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.635	0.770	0.025	0.030	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830	REF.	0.190	REF.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900 REF.		0.114 REF.		
L2	1.400	1.700	0.055	0.067	
L3	1.600 REF.		0.063 REF.		
L4	0.600	1.000	0.024	0.039	
Ф	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.250 REF.		0.207 REF.		



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